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| FORM: PTO-1449 (REV: 7-80) | U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE | Atty Docket No: 2003-0930.00/US | Serial No: 10/719,047 Not Assigned |
| INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b)) (use several sheets if necessary) | | Applicant: Micron Technology, Inc. | |
| | | Filing Date: November 20, 2003 | Group: Not Assigned |

U.S. PATENT DOCUMENTS

| Examiner Initial | Document Number | Date | Name | Class | Subclass | |
|---------------------|--------------------|---------|---------------|-------|----------|--|
| MP | AA 6,297,152 | 10/2001 | Itoh et al. | 438 | 649 | |
| MP | AB 6,451,644 | 09/2002 | Yu | 438 | 230 | |
| MP | AC 6,365,507 | 04/2002 | Hu | 438 | 627 | |
| MP | AD 6,486,060 | 11/2002 | Hermes et al. | 438 | 649 | |
| | AE | | | | | |
| | AF | | | | | |
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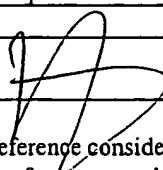
FOREIGN PATENT DOCUMENTS

| Examiner Initial | Document Number | Date | Country | Class | Subclass | Translation Yes | No |
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OTHER ART (including author, title, date, pertinent pages, etc.)

| | | | |
|----|----|--|--|
| MP | AO | | Copending Application: "Conductive Transistor Structure for a Semiconductor Device and Method for Forming Same", Serial number 10/418,412, Docket Number 2002-1377.00, Filed April 16, 2003. |
| | AP | | |
| | AQ | | |
| | AR | | |

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| Examiner:  | Date Considered: 4/05 |
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication with applicant.



Sheet: 1 of: 1

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| | | Filing Date: November 20, 2003 | Group: 2811 |

U.S. PATENT DOCUMENTS

| Examiner Initial | Document Number | Date | Name | Class | Subclass | |
|---------------------|--------------------|------------|-------------|-------|----------|--|
| MP | AA 6,589,884 | 07/08/2003 | Torek | 438 | 755 | |
| MP | AB 6,221,762 | 04/24/2001 | Byun et al. | 438 | 643 | |
| MP | AC 6,075,274 | 06/13/2000 | Wu et al. | 257 | 413 | |
| | AD | | | | | |
| | AE | | | | | |
| | AF | | | | | |
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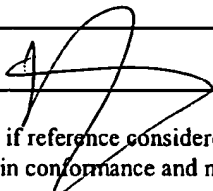
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